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# DAC1008D750

Dual 10-bit DAC; up to 750 Msps; 2×, 4× or 8× interpolating with JESD204A interface

Rev. 04 — 2 July 2012

**Product data sheet** 

# 1. General description

The DAC1008D750 is a high-speed 10-bit dual channel Digital-to-Analog Converter (DAC) with selectable  $2\times$ ,  $4\times$  or  $8\times$  interpolating filters optimized for multi-carrier WCDMA transmitters.

Because of its digital on-chip modulation, the DAC1008D750 allows the complex pattern provided through lane 0, lane 1, lane 2 and lane 3, to be converted up from baseband to IF. The mixing frequency is adjusted via a Serial Peripheral Interface (SPI) with a 32-bit Numerically Controlled Oscillator (NCO) and the phase is controlled by a 16-bit register.

The DAC1008D750 also includes a  $2\times$ ,  $4\times$  or  $8\times$  clock multiplier which provides the appropriate internal clocks and an internal regulation to adjust the output full-scale current.

The input data format is serial according to JESD204A specification. This new interface has numerous advantages over the traditional parallel one: easy PCB layout, lower radiated noise, lower pin count, self-synchronous link, skew compensation. The maximum number of lanes of the DAC1008D750 is 4 and its maximum serial data rate is 3.125 Gbps.

The Multiple Device Synchronization (MDS) guarantees a maximum skew of one output clock period between several DAC devices. MDS incorporates modes: Master/slave and All slave mode.

#### 2. Features and benefits

- Dual 10-bit resolution
- 750 Msps maximum update rate
- Selectable 2x, 4x or 8x interpolation filters
- Input data rate up to 312.5 Msps
- Very low-noise cap-free integrated PLL
- 32-bit programmable NCO frequency
- Four JESD204A serial input lanes
- 1.8 V and 3.3 V power supplies
- LVDS compatible clock inputs

- IMD3: 80 dBc; f<sub>s</sub> = 737.28 Msps; f<sub>o</sub> = 140 MHz
- ACPR: 64 dBc; two carriers WCDMA;
   f<sub>s</sub> = 737.28 Msps; f<sub>o</sub> = 153.6 MHz
- Typical 1.26 W power dissipation at 4× interpolation, PLL off and 740 Msps
- Power-down mode and Sleep modes
- Differential scalable output current from 1.6 mA to 22 mA
- On-chip 1.29 V reference
- External analog offset control (10-bit auxiliary DACs)
- Internal digital offset control
- Inverse (sin x) / x function



- Two's complement or binary offset data
   Fully compatible SPI port format
- LMF = 421 or LMF = 211 support Industrial temperature range from -40 °C to +85 °C
- Differential CML receiver with embedded termination
   Integrated PLL can be bypassed
- Synchronization of multiple DAC outputs Embedded complex modulator

## 3. Applications

- Wireless infrastructure: LTE, WiMAX, GSM, CDMA, WCDMA, TD-SCDMA
- Communication: LMDS/MMDS, point-to-point
- Direct Digital Synthesis (DDS)
- Broadband wireless systems
- Digital radio links
- Instrumentation
- Automated Test Equipment (ATE)

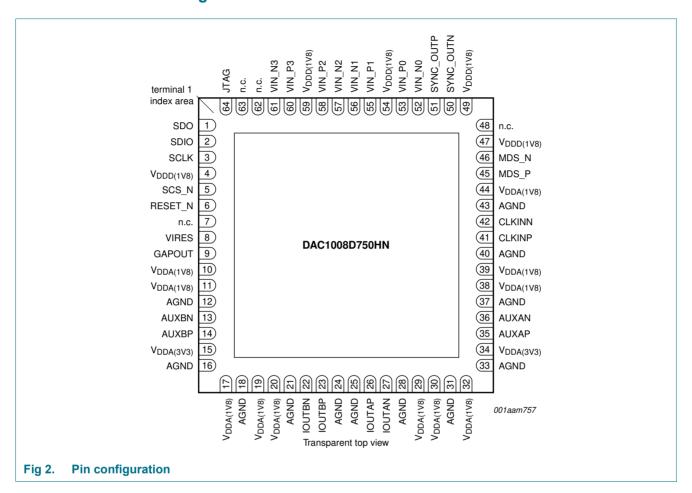
# 4. Ordering information

#### Table 1. Ordering information

Type number	Package	ckage								
	Name	Description	Version							
DAC1008D750HN	HVQFN64	plastic thermal enhanced very thin quad flat package; no leads; 64 terminals; body $9\times 9\times 0.85$ mm	SOT804-3							

# 6. Pinning information

### 6.1 Pinning



### 6.2 Pin description

Table 2. Pin description

14510 2. 1 111 400011	ption		
Symbol	Pin	Type <sup>[1]</sup>	Description
SDO	1	0	SPI data output
SDIO	2	I/O	SPI data input/output
SCLK	3	I	SPI clock
V <sub>DDD(1V8)</sub>	4	Р	digital supply voltage 1.8 V
SCS_N	5	I	SPI chip select (active LOW)
RESET_N	6	I	general reset (active LOW)
n.c.	7	-	not connected
VIRES	8	I/O	DAC biasing resistor
GAPOUT	9	I/O	bandgap input/output voltage
V <sub>DDA(1V8)</sub>	10	Р	analog supply voltage 1.8 V
V <sub>DDA(1V8)</sub>	11	Р	analog supply voltage 1.8 V

 Table 2.
 Pin description ...continued

Table 2.	Pili descripti			
Symbol	P	Pin '	Type <sup>[1]</sup>	Description
AGND	1	2	G	analog ground
AUXBN	1	3	0	complementary auxiliary DAC B output
AUXBP	1	4	0	auxiliary DAC B output
V <sub>DDA(3V3)</sub>	1	5	Р	analog supply voltage 3.3 V
AGND	1	6	G	analog ground
V <sub>DDA(1V8)</sub>	1	7	Р	analog supply voltage 1.8 V
AGND	1	8	G	analog ground
V <sub>DDA(1V8)</sub>	1	9	Р	analog supply voltage 1.8 V
V <sub>DDA(1V8)</sub>	2	.0	Р	analog supply voltage 1.8 V
AGND	2	.1	G	analog ground
IOUTBN	2	2	0	complementary DAC B output current
IOUTBP	2	.3	0	DAC B output current
AGND	2	<u>!</u> 4	G	analog ground
AGND	2	25	G	analog ground
IOUTAP	2	26	0	DAC A output current
IOUTAN	2	.7	0	complementary DAC A output current
AGND	2	28	G	analog ground
V <sub>DDA(1V8)</sub>	2	.9	Р	analog supply voltage 1.8 V
V <sub>DDA(1V8)</sub>	3	0	Р	analog supply voltage 1.8 V
AGND	3	1	G	analog ground
V <sub>DDA(1V8)</sub>	3	2	Р	analog supply voltage 1.8 V
AGND	3	3	G	analog ground
V <sub>DDA(3V3)</sub>	3	4	Р	analog supply voltage 3.3 V
AUXAP	3	5	0	auxiliary DAC A output current
AUXAN	3	6	0	complementary auxiliary DAC A output current
AGND	3	7	G	analog ground
V <sub>DDA(1V8)</sub>	3	8	Р	analog supply voltage 1.8 V
V <sub>DDA(1V8)</sub>	3	9	Р	analog supply voltage 1.8 V
AGND	4	.0	G	analog ground
CLKINP	4	1	l	clock input
CLKINN	4	2	l	complementary clock input
AGND	4	.3	G	analog ground
V <sub>DDA(1V8)</sub>	4	4	Р	analog supply voltage 1.8 V
MDS_P	4	-5	I/O	multi-device synchronization
MDS_N	4	-6	I/O	complementary multi-device synchronization
V <sub>DDD(1V8)</sub>	4	.7	Р	digital supply voltage 1.8 V
n.c.	4	8	-	not connected
V <sub>DDD(1V8)</sub>	4	.9	P	digital supply voltage 1.8 V
SYNC_OL			0	synchronization request to transmitter, complementary output
SYNC_OL	JTP 5	1	0	synchronization request to transmitter

Table 2. Pin description ...continued

Symbol	Pin	Type <sup>[1]</sup>	Description
VIN_N0	52	I	serial interface lane 0 negative input
VIN_P0	53	I	serial interface lane 0 positive input
V <sub>DDD(1V8)</sub>	54	Р	digital supply voltage 1.8 V
VIN_P1	55	I	serial interface lane 1 positive input
VIN_N1	56	I	serial interface lane 1 negative input
VIN_N2	57	I	serial interface lane 2 negative input
VIN_P2	58	I	serial interface lane 2 positive input
V <sub>DDD(1V8)</sub>	59	Р	digital supply voltage 1.8 V
VIN_P3	60	I	serial interface lane 3 positive input
VIN_N3	61	I	serial interface lane 3 negative input
n.c.	62	-	not connected
n.c.	63	-	not connected
JTAG	64	I	JTAG test mode select (must be grounded)
GND	H <sup>[2]</sup>	G	ground

<sup>[1]</sup> P: power supply; G: ground; I: input; O: output.

# 7. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DDA(3V3)</sub>	analog supply voltage (3.3 V)		-0.5	+4.6	V
V <sub>DDA(1V8)</sub>	analog supply voltage (1.8 V)		-0.5	+2.5	V
$V_{DDD}$	digital supply voltage		-0.5	+2.5	V
T <sub>stg</sub>	storage temperature		-55	+150	°C
T <sub>amb</sub>	ambient temperature		-40	+85	°C
Tj	junction temperature		-40	+125	°C

# 8. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient		<sup>[1]</sup> 18.7	K/W
R <sub>th(j-c)</sub>	thermal resistance from junction to case		<sup>[1]</sup> 6.7	K/W

<sup>[1]</sup> Complies with JEDEC test board, in free air.

<sup>[2]</sup> H = heatsink (exposed die pad to be soldered to GND. A minimum of 81 thermal vias are required).

### 9. Characteristics

#### Table 5. Characteristics

 $V_{DDA(1V8)} = V_{DDD} = 1.7 \text{ V to } 1.9 \text{ V}; V_{DDA(3V3)} = 3.13 \text{ V to } 3.47 \text{ V}; \text{AGND and GND are shorted together}; T_{amb} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}; \text{typical values measured at } V_{DDA(1V8)} = V_{DDD} = 1.8 \text{ V}; V_{DDA(3V3)} = 3.3 \text{ V}; T_{amb} = +25 ^{\circ}\text{C}; R_L = 50 ^{\circ}\text{C}; I_{O(fs)} = 20 \text{ mA}; \text{maximum sample rate}; PLL \text{ off unless otherwise specified.}$ 

Vpdp(178)   digital supply voltage (1.8 V)   Vpdp(178)   analog supply voltage (1.8 V)   Ipdp(30.3)   analog supply current (3.3 V)   Ipdp(30.3)   analog supply current (1.8 V)   Ipdp(30.3)   digital supply current (1.8 V)   Ipdp(17.8)   digital supply current (1.8 V)   Ipdp(17.8)   Ipdp(17.8)   digital supply current (1.8 V)   Ipdp(17.8)	Symbol	Parameter	Conditions	Test <sup>[1]</sup>	Min	Тур	Max	Unit
(1.8 V)	$V_{DDA(3V3)}$			I	3.13	3.3	3.47	V
	$V_{DDD(1V8)}$			I	1.7	1.8	1.9	V
Composition	V <sub>DDA(1V8)</sub>			I	1.7	1.8	1.9	V
A   Interpolation; NCO on   A   Interpolation; NCO on     Indicators   Interpolation; NCO on     Interpolation; NCO off;     Interpolation; NCO off;     Interpolation; NCO on     Interpolation; NCO off;     Interpolation; NCO on     Interpolation; NC	I <sub>DDA(3V3)</sub>			I	-	41	-	mA
(1.8 V)	I <sub>DDD(1V8)</sub>			I	-	356	-	mA
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	I <sub>DDA(1V8)</sub>			I	-	421	-	mA
$\begin{array}{c} 4 \times \text{ interpolation; NCO off;} \\ DAC \ Q \ \text{off} \\ \\ \hline \\ f_s = 740 \ \text{Msps;} \qquad C \qquad - \qquad 1.26 \qquad - \qquad V \\ \hline \\ 4 \times \text{ interpolation; NCO off} \\ \hline \\ f_s = 740 \ \text{Msps;} \qquad C \qquad - \qquad 1.50 \qquad - \qquad V \\ \hline \\ 4 \times \text{ interpolation; NCO off} \\ \hline \\ f_s = 740 \ \text{Msps;} \qquad C \qquad - \qquad 1.50 \qquad - \qquad V \\ \hline \\ 4 \times \text{ interpolation; NCO on} \\ \hline \\ f_s = 625 \ \text{Msps;} \qquad C \qquad - \qquad 1.29 \qquad - \qquad V \\ \hline \\ 2 \times \text{ interpolation; NCO on} \\ \hline \\ Power-down \ \text{mode;} \\ f_o = 19 \ \text{MHz;} \ f_s = 740 \ \text{Msps;} \\ 4 \times \text{ interpolation; NCO on} \\ \hline \\ Power-down \ \text{mode} \\ \hline \\ DAC \ A \ \text{and DAC B;} \qquad I \qquad - \qquad 0.60 \qquad - \qquad V \\ \hline \\ Power-down \ \text{mode} \\ \hline \\ DAC \ A \ \text{and DAC B;} \qquad I \qquad - \qquad 0.80 \qquad - \qquad V \\ \hline \\ Timing \ \text{specifications} \\ \hline \\ Timing \ \text{specifications} \\ \hline \\ t_{d(\text{gestart})} \qquad \text{restart delay time} \qquad \text{from full Power-down mode} \qquad - \qquad 300 \qquad - \qquad \text{not} \\ \hline \\ To \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ $	$\Delta I_{ m DDD}$		•	I	-	54	-	mA
$\frac{4\times \text{ interpolation; NCO off}}{f_s = 740 \text{ Msps;}} \qquad C \qquad - \qquad 1.50 \qquad - \qquad V \\ \frac{4\times \text{ interpolation; NCO on}}{f_s = 625 \text{ Msps;}} \qquad C \qquad - \qquad 1.29 \qquad - \qquad V \\ \frac{2\times \text{ interpolation; NCO off}}{f_s = 625 \text{ Msps;}} \qquad C \qquad - \qquad 1.46 \qquad - \qquad V \\ \frac{2\times \text{ interpolation; NCO on}}{2\times \text{ interpolation; NCO on}} \qquad - \qquad 1.46 \qquad - \qquad V \\ \frac{Power-down \text{ mode;}}{f_0 = 19 \text{ MHz;} f_s = 740 \text{ Msps;}} \\ 4\times \text{ interpolation; NCO on} \qquad - \qquad 0.04 \qquad - \qquad V \\ \frac{Power-down \text{ mode}}{Power-down \text{ mode}} \qquad - \qquad 0.60 \qquad - \qquad V \\ \frac{Power-down \text{ mode}}{Power-down \text{ mode}} \qquad - \qquad 0.80 \qquad - \qquad V \\ \frac{Power-down \text{ mode}}{Sleep \text{ mode}} \qquad - \qquad 0.80 \qquad - \qquad V \\ \frac{Timing \text{ specifications}}{Sleep \text{ mode}} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ \frac{Tomegraphics}{Tomegraphics} \qquad - \qquad 300 \qquad - \qquad m \\ Tom$	P <sub>tot</sub>	total power dissipation	4× interpolation; NCO off;	С	-	0.80	-	W
$\frac{4\times \text{ interpolation; NCO on}}{f_s = 625 \text{ Msps;}}  C  -  1.29  -  V \\ \frac{2\times \text{ interpolation; NCO off}}{f_s = 625 \text{ Msps;}}  C  -  1.46  -  V \\ \frac{2\times \text{ interpolation; NCO on}}{2\times \text{ interpolation; NCO on}}  -  \frac{1.46  -  V}{1.46  -  V} \\ \frac{1.46  -  V}{2\times \text{ interpolation; NCO on}}  -  \frac{1.46  -  V}{2\times $				С	-	1.26	-	W
				С	-	1.50	-	W
				С	-	1.29	-	W
				С	-	1.46	-	W
Power-down mode			$f_0 = 19 \text{ MHz}; f_s = 740 \text{ Msps};$					
$\frac{\text{Power-down mode}}{\text{DAC A and DAC B;}}  \text{I}  \text{-}  0.80  \text{-}  \text{V}$ $\frac{\text{Sleep mode}}{\text{Sleep mode}}$ $\frac{\text{Timing specifications}}{\text{td}_{\text{(startup)}}}  \text{start-up delay time}  \text{from full Power-down mode}  \text{-}  20  \text{-}  \text{m}}{\text{td}_{\text{(restart)}}}  \text{restart delay time}  \text{from Sleep mode}  \text{-}  300  \text{-}  \text{n}}{\text{td}_{\text{(restart)}}}$			,	I	-	0.04	-	W
				I	-	0.60	-	W
$t_{d(startup)}$ start-up delay time from full Power-down mode - 20 - m $t_{d(restart)}$ restart delay time from Sleep mode - 300 - n			•	I	-	0.80	-	W
t <sub>d(restart)</sub> restart delay time from Sleep mode - 300 - n	Timing spec	cifications						
ron	t <sub>d(startup)</sub>	start-up delay time	from full Power-down mode		-	20	-	ms
rol		restart delay time	from Sleep mode		-	300	-	ns
	t <sub>lock</sub>	lock time	maximum input rate	[2	2] _	11	-	μs

Table 5. Characteristics ...continued

 $V_{DDA(1V8)} = V_{DDD} = 1.7 \text{ V to } 1.9 \text{ V}; V_{DDA(3V3)} = 3.13 \text{ V to } 3.47 \text{ V}; \text{ AGND and GND are shorted together; } T_{amb} = -40 \text{ }^{\circ}\text{C} \text{ to } +85 \text{ }^{\circ}\text{C}; \text{ typical values measured at } V_{DDA(1V8)} = V_{DDD} = 1.8 \text{ V}; V_{DDA(3V3)} = 3.3 \text{ V}; T_{amb} = +25 \text{ }^{\circ}\text{C}; R_L = 50 \text{ }^{\circ}\text{C}; I_{O(fs)} = 20 \text{ mA}; maximum sample rate; PLL off unless otherwise specified.}$ 

Symbol	Parameter	Conditions	Test <sup>[1]</sup>	Min	Тур	Max	Unit
Clock input	s (CLKINN, CLKINP) <sup>[3]</sup>						
Vi	input voltage	range: CLK+ or CLK– $ V_{gpd}  < 50 \text{ mV}^{[4]}$	С	825	-	1575	mV
V <sub>idth</sub>	input differential threshold voltage	$ V_{gpd}  < 50 \text{ mV}^{[4]}$	С	-100	-	+100	mV
R <sub>i</sub>	input resistance		D	-	10	-	$M\Omega$
C <sub>I</sub>	input capacitance		D	-	0.5	-	pF
Digital input	ts (SDO, SDIO, SCLK, SC	S_N, RESET_N)					
V <sub>IL</sub>	LOW-level input voltage		С	GND	-	$0.3V_{DDD}$	V
V <sub>IH</sub>	HIGH-level input voltage		С	$0.7V_{DDD}$	-	$V_{DDD}$	V
l <sub>IL</sub>	LOW-level input current	$V_{IL} = 0.3V_{DDD} V$	I	-	1	-	μΑ
Іін	HIGH-level input current	$V_{IH} = 0.7V_{DDD} V$	I	-	1	-	μΑ
Digital outp	uts (SDO, SDIO)						
V <sub>OL</sub>	LOW-level output voltage	I <sub>load</sub> = 2 mA	С	GND	-	0.13	V
V <sub>OH</sub>	HIGH-level output voltage	I <sub>load</sub> = 2 mA	С	1.65	-	$V_{DDD}$	V
Digital input	ts (Vin_p/Vin_n) <sup>[5]</sup>						
V <sub>I(cm)</sub>	common-mode input voltage		D	-	0.78	-	V
$V_{I(dif)(p-p)}$	peak-to-peak differential input voltage		D	175	-	1000	mV
Z <sub>tt</sub>	V <sub>tt</sub> source impedance		D	-	0.7	-	Ω
ΔZ <sub>i</sub>	differential input impedance		D	-	100	-	Ω
Digital outp	uts (SYNC_OUTN/SYNC_	OUTP) <sup>[6]</sup>					
$V_{o(cm)}$	common-mode output voltage		С	-	1.18	-	V
$V_{o(dif)(p-p)}$	peak-to-peak differential output voltage		С	-	0.45	-	V
Digital input	ts/outputs (MDS_N/MDS_	<b>P</b> )					
$V_{o(dif)(p-p)}$	peak-to-peak differential output voltage		D	-	600	-	mV
$C_{o(L)}$	Output load capacitance	between pins GND and MDS_N or MDS_P	D	-	-	10	pF
Cı	Input capacitance	between pins GND and MDS_N or MDS_P	D	-	0.3	-	pF
AC1008D750 4						© IDT 2013	2. All rights rese

Table 5. Characteristics ...continued

 $V_{DDA(1V8)} = V_{DDD} = 1.7 \text{ V to } 1.9 \text{ V}; V_{DDA(3V3)} = 3.13 \text{ V to } 3.47 \text{ V}; \text{ AGND and GND are shorted together; } T_{amb} = -40 \text{ }^{\circ}\text{C} \text{ to } +85 \text{ }^{\circ}\text{C}; \text{ typical values measured at } V_{DDA(1V8)} = V_{DDD} = 1.8 \text{ V}; V_{DDA(3V3)} = 3.3 \text{ V}; T_{amb} = +25 \text{ }^{\circ}\text{C}; R_L = 50 \text{ }^{\circ}\text{C}; I_{O(fs)} = 20 \text{ mA}; maximum sample rate; PLL off unless otherwise specified.}$ 

Symbol	Parameter	Conditions	Test <sup>[1]</sup>	Min	Тур	Max	Unit
Analog output	ts (IOUTAP, IOUTAN, IO	OUTBP, IOUTBN)					
$I_{O(fs)}$	full-scale output current	register value = 00h (see Table 13 and Table 14)	D	-	1.6	-	mA
		register = default value (see Table 13 and Table 14)		-	20	-	mA
V <sub>O</sub>	output voltage	compliance range	D	1.8	-	$V_{DDA(3V3)}$	V
R <sub>o</sub>	output resistance		D	-	250	-	kΩ
Co	output capacitance		D	-	3	-	pF
ΔE <sub>O</sub>	offset error variation		D	-	6	-	ppm/°(
$\Delta E_G$	gain error variation		D	-	18	-	ppm/°(
Reference vol	tage output (GAPOUT						
V <sub>O(ref)</sub>	reference output voltage		С	1.24	1.29	1.34	V
I <sub>O(ref)</sub>	reference output current	external voltage 1.2 V	С	-	40	-	μΑ
$\Delta V_{O(ref)}$	reference output voltage variation		С	-	117	-	ppm/°(
Analog auxilia	ary outputs (AUXAP, A	UXAN, AUXBP and AUXBN)					
I <sub>O(aux)</sub>	auxiliary output curren	t differential outputs	ı	-	2.2	-	mA
$V_{O(aux)}$	auxiliary output voltage	compliance range	D	0	-	2	V
N <sub>DAC(aux)mono</sub>	auxiliary DAC monotonicity	guaranteed	D	-	10	-	bits
Input timing (	Vin_p/Vin_n)						
f <sub>data</sub>	data rate	2× interpolation	D	-	-	312.5	Msps
		4× interpolation	D	-	-	187.5	Msps
		8× interpolation	D	-	-	93.75	Msps
f <sub>bit</sub>	bit rate	serial input	D	0.7	-	3.125	Gbps
Output timing	(IOUTAP, IOUTAN, IOU	JTBP, IOUTBN)					
f <sub>s</sub>	sampling rate		D	-	-	750	Msps
t <sub>s</sub>	settling time	up to 0.5 LSB	D	-	20	-	ns
NCO frequenc	cy range; f <sub>s</sub> = 750 Msps	3					
f <sub>NCO</sub>	NCO frequency	register value = 00000000h (see Table 21 to Table 24)	D	-	0	-	MHz
		register value = FFFFFFFFh (see Table 21 to Table 24)	D	-	750	-	MHz
f <sub>step</sub>	step frequency	·	D	-	0.175	-	Hz
	CO frequency range; f	; = 750 Msps					
f <sub>NCO</sub>	NCO frequency	reg value = 00000000h (see Table 21 to Table 24)	D	-	0	-	MHz
		reg value = F8000000h (see Table 21 to Table 24)	D	-	726.4	-	MHz
DAC1008D750 4		,				© IDT 2012	. All rights rese
Product data sh	oot	Rev. 04 — 2 July 20	12				9 01

#### Table 5. Characteristics ... continued

 $V_{DDA(1V8)} = V_{DDD} = 1.7 \text{ V to } 1.9 \text{ V}; V_{DDA(3V3)} = 3.13 \text{ V to } 3.47 \text{ V}; \text{ AGND and GND are shorted together; } T_{amb} = -40 \text{ }^{\circ}\text{C} \text{ to } +85 \text{ }^{\circ}\text{C}; \text{ typical values measured at } V_{DDA(1V8)} = V_{DDD} = 1.8 \text{ V}; V_{DDA(3V3)} = 3.3 \text{ V}; T_{amb} = +25 \text{ }^{\circ}\text{C}; R_L = 50 \text{ }^{\circ}\text{C}; I_{O(fs)} = 20 \text{ mA}; maximum sample rate; PLL off unless otherwise specified.}$ 

Symbol	Parameter	Conditions	Test <sup>[1]</sup>	Min	Тур	Max	Unit
f <sub>step</sub>	step frequency		D	-	23.4	-	MHz
Dynamic per	formances						
SFDR	spurious-free dynamic range	$f_{data} = 92.16 \text{ Msps;}$ $f_{s} = 737.28 \text{ Msps; } 8\times;$ $BW = f_{data} / 2; PLL \text{ on}$		[7]			
		f <sub>o</sub> = 4 MHz at -1 dBFS	С	-	77	-	dBc
		$f_{data} = 184.32 \text{ Msps;}$ $f_{s} = 737.28 \text{ Msps; } 4\times;$ $BW = f_{data} / 2$		[7]			
		$f_0$ = 19 MHz at $-1$ dBFS	С	-	74.5	-	dBc
		$f_{data}$ = 312.5 Msps; $f_s$ = 625 Msps; 2×; BW = $f_{data}$ / 2		[7]			
		$f_0$ = 19 MHz at $-1$ dBFS	I	-	75	-	dBc
SFDR <sub>RBW</sub>	restricted bandwidth spurious-free dynamic range	$f_s$ = 737.28 Msps; 4× interpolation; $f_o$ = 153.6 MHz at –1 dBFS; BW = 100 MHz	I	[7] _	81.5	-	dBc
		$f_s$ = 737.28 Msps; 4× interpolation; $f_o$ = 153.6 MHz at –1 dBFS; BW = 20 MHz	С	[7] _	84	-	dBc
IMD3	third-order intermodulation distortion	$f_{o1}$ = 95 MHz; $f_{o2}$ = 97 MHz; $f_{s}$ = 737.28 Msps; $4 \times$ interpolation	С	[7] _ [8]	76		dBc
		$f_{o1}$ = 153.1 MHz; $f_{o2}$ = 154.1 MHz; $f_{s}$ = 737.28 Msps; $4 \times$ interpolation	I	[7] _ [8]	81	-	dBc
		$f_{o1}$ = 137 MHz; $f_{o2}$ = 143 MHz; $f_{s}$ = 737.28 Msps; $4 \times$ interpolation	С	[7] <sub>-</sub> [8]	80	-	dBc

#### Table 5. Characteristics ... continued

 $V_{DDA(1V8)} = V_{DDD} = 1.7 \text{ V to } 1.9 \text{ V}; V_{DDA(3V3)} = 3.13 \text{ V to } 3.47 \text{ V}; AGND and GND are shorted together; } T_{amb} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}; typical values measured at } V_{DDA(1V8)} = V_{DDD} = 1.8 \text{ V}; V_{DDA(3V3)} = 3.3 \text{ V}; T_{amb} = +25 ^{\circ}\text{C}; R_L = 50 ^{\circ}\text{C}; I_{O(fs)} = 20 \text{ mA};$  maximum sample rate; PLL off unless otherwise specified.

Symbol	Parameter	Conditions	Test <sup>[1]</sup>	Min	Тур	Max	Unit
ACPR	adjacent channel power ratio	NCO on; $4\times$ interpolation; $f_s = 737.28$ Msps; $f_o = 96$ MHz		[7]			
		1 carrier; BW = 5 MHz	С	-	67	-	dBc
		2 carriers; BW = 10 MHz	С	-	64	-	dBc
		4 carriers; BW = 20 MHz	С	-	60	-	dBc
		NCO on; $4\times$ interpolation; $f_s = 737.28$ Msps; $f_o = 153.6$ MHz		[7]			
		1 carrier; BW = 5 MHz	С	-	67	-	dBc
		2 carriers; BW = 10 MHz	С	-	64	-	dBc
		4 carriers; BW = 20 MHz	С	-	59	-	dBc
NSD	noise spectral density	$f_s$ = 737.28 Msps; 4× interpolation; $f_o$ = 153.6 MHz at 0 dBFS	I	[7] _	-145	-	dBm/Hz

- [1] D = guaranteed by design; C = guaranteed by characterization; I = 100 % industrially tested.
- [2] Delay between the deassertion of bits FORCE\_RESET\_FCLK and FORCE\_RESET\_DCLK and the deassertion of the sync signal. It reflects the delay required by DAC1008D750 to lock to a JESD204A stream. It supposes that the TX is already transmitting K28.5 characters in error-free conditions.
- [3] CLKINP/CLKINN inputs are at differential LVDS levels. An external termination resistor with a value of between 80  $\Omega$  and 120  $\Omega$  (see Figure 15) should be connected across the pins.
- [4] |V<sub>gpd</sub>| represents the ground potential difference voltage. This is the voltage that results from current flowing through the finite resistance and the inductance between the receiver and the driver circuit ground voltage.
- [5] Vin\_p and Vin\_n inputs are differential CML inputs. They are terminated internally to  $V_{tt}$  via 50  $\Omega$  (see Figure 4).
- [6] SYNC\_OUTP/SYNC\_OUTN outputs are differential LVDS outputs. They must be terminated by a resistor with a value of between 80  $\Omega$  and 120  $\Omega$ .
- [7] Optimum performances at high sampling rate (> 650 Msps) will be achieved with  $V_{DDA(1V8)}$  = 1.8 V  $\pm$  2 %
- [8] IMD3 rejection with -6 dBFS/tone.

## 10. Application information

### 10.1 General description

The DAC1008D750 is a dual 10-bit DAC operating up to 750 Msps. With a maximum input data rate of up to 312.5 Msps and a maximum output sampling rate of 750 Msps, the DAC1008D750 allows more flexibility for wide bandwidth and multi-carrier systems. Combined with its quadrature modulator and 32-bit NCO, the DAC1008D750 simplifies the frequency selection of the system. This is also possible because of the  $2\times$ ,  $4\times$  or  $8\times$  interpolation filters which remove undesired images.

DAC1008D750 supports the following JESD204A key features:

- 10-bit/8-bit decoding
- Code group synchronization
- inter-lane alignment
- 1 +  $x^{14}$  +  $x^{15}$  scrambling polynomial
- · Character replacement
- TX/RX synchronization management via SYNC signals
- Multiple Converter Device Alignment-Multiple Lanes (MCDA-ML) device

DAC1008D750 can be interfaced with any logic device that features high-speed SERDES functionality. This macro is now widely available in FPGA from different vendors. Standalone SERDES ICs can also be used.

To enhance the intrinsic board layout simplification of the JESD204A standard, IDT includes polarity swapping for each of the lanes and additionally offers lane swapping. Each physical lane can be configured logically as lane0, lane1, lane2 or lane3.

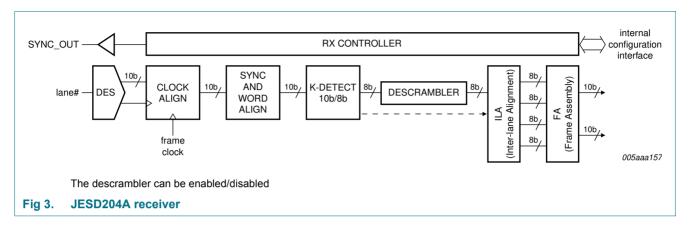
This device is MCDA-ML compliant, offering inter-lane alignment between several devices. Samples alignment between devices is maintained up to output level because of an IDT proprietary mechanism. One device is configured as the master and all the others are configured as slaves. These will automatically align their output samples to the master ones. Therefore, a system with several DAC1008D750s can produce data with a quaranteed alignment of less than 1 DAC output clock period.

Each DAC generates two complementary current outputs on pins IOUTAP/IOUTAN and IOUTBP/IOUTBN. This provides a full-scale output current of up to 20 mA. An internal reference is available for the reference current which is externally adjustable using pin VIRES.

The DAC1008D750 must be configured before operating. Therefore, it features an SPI slave interface to access internal registers. Some of these registers also provide information about the JESD204A interface status.

The DAC1008D750 requires supplies of both 3.3 V and 1.8 V. The 1.8 V supply has separate digital and analog power supply pins. The clock input is LVDS compliant.

#### 10.2 JESD204A receiver



The JEDEC204A defines the following parameters:

L is the number of lanes per link

M is the number of converters per device

F is the number of bytes per frame clock period

The DAC1008D750 supports both LMF = 421 and LMF = 211. The current setting is configurable via the SPI registers interface.

The complete Digital Layer Processing (DLP) adds a variable delay on each lane path. This is mainly because of the inter-lane alignment.

Table 6. Digital Layer Processing Latency

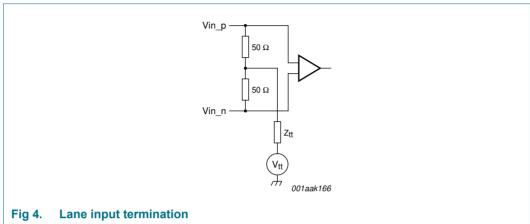
Symbol	Parameter	Conditions	Test <sup>[1]</sup>	Min	Тур	Max	Unit
t <sub>d</sub>	delay time	digital layer processing delay	D	13	-	28	cycle <sup>[2]</sup>

<sup>[1]</sup> D = guaranteed by design.

<sup>[2]</sup> Frame clock cycle.

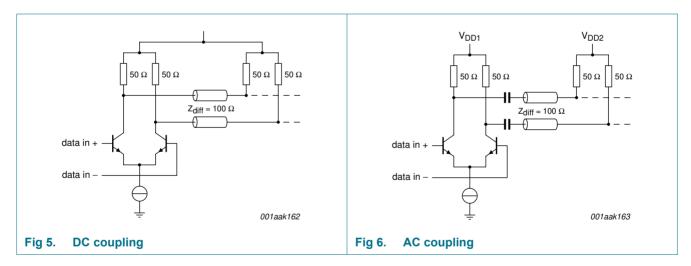
#### 10.2.1 Lane input

Each lane is CML compliant. It is terminated to a common voltage with an integrated 50  $\Omega$ resistor.



The common-mode voltage is programmable by the SET VCM VOLTAGE register as shown in Table 75 on page 56.

DC coupling is only possible if both the DAC and the transmitter have the same common-mode voltage. If this is not the case, AC coupling is required.



The deserializer performs the incoming data clock recovery and also the serial-to-parallel conversion. Therefore, each lane includes its own PLL that must first lock.

The clock alignment module transfers the data from the regenerated clock to the frame clock domain. The frequency of both clocks is the same but the phase relationship between the clocks is unknown.

#### 10.2.2 Sync and word align

As stated in JESD204A, the transmitter and the receiver first have to synchronize. This is achieved through the SYNC OUT signals and a sync pattern (K28.5 symbol). The receiver (i.e. DAC1008D750) first drives its SYNC OUT outputs. The sync pattern is continuously sent until the receiver deasserts the SYNC OUT signal.

The lane processing makes use of the sync patterns to synchronize the datastream, determine the initial running disparity and extract the 10-bit word from the incoming datastream (word-alignment).

The SYNC\_OUT signal is also used during normal operation by the DAC1008D750 to request a link reinitialization. This occurs when the 10b/8b module loses synchronization.

The SYNC\_OUT signal conforms to LVDS signaling. Its common-mode voltage and its single-ended peak amplitude can be programmed using SET\_SYNC\_LEVEL bits in the SET\_SYNC registers (see Table 77 on page 56).

SYNC\_OUT is asynchronous with the frame clock. There is no timing specification with respect to the CLKINP and CLKINN inputs.

### 10.2.3 Comma detection and word align

This stage monitors the datastream for code characters (Comma detection), decodes the words to bytes (octets) and performs optional character replacement as part of frame/lane alignment monitoring and correction. This module provides the required control signals to the RX-controller and ILA.

This module decodes the 10-bit words into 8-bit words (octets). The decoding table is specified in the IEEE 802.3-2005 specification. During decoding, the disparity is calculated according to the disparity rules mentioned in the same specification IEEE 802.3-2005. When the disparity counter is more than +2 or less than –2, an error will be generated.

The following comma symbols are detected during data transmission irrespective of the running disparity:

/K/ = K28.5

/F/ = K28.7

/A/ = K28.3

/R/ = K28.0

/Q/ = K28.4

A flag is sent to the control interface to reflect detected commas in registers.

The following flags are also triggered according to the following definitions:

- VALID: a code group that is found in the column of the 10b/8b decoding tables according to the current running disparity.
- DISPARITY ERROR: The received code group exists in the 10b/8b decoding table, but is not found in the proper column according to the current running disparity.
- NOT-IN-TABLE (NIT) ERROR: The received code group is not found in the 10b/8b decoding table for either disparity.
- INVALID: a code group that either shows a disparity error or that does not exist in the 10b/8b decoding table.

DAC1008D750 supports character replacement whatever the state of the descrambler. When scrambling is not active, the received K28.3 /A/ or K28.7 /F/ will be replaced by the previous sample. When scrambling is active, the corresponding data octet D28.3 (0xC) or D28.7 (0xFC) will be used.

#### 10.2.4 Descrambler

The descrambler is a 16-bit parallel self-synchronous descrambler based on the polynomial  $1 + x^{14} + x^{15}$ . This processing can be turned off.

#### 10.2.5 Inter-lane alignment

This feature removes strict PCB design skew compensation between the lanes.

#### 10.2.5.1 Single device operation

This module handles the alignment of the four data streams. Because of inter-lane skew and each PLL per lane concept, these alignment characters may be received at different times by the receivers. After the synchronization period, the lock signal will be HIGH. This enables the receipt of K28.3 /A/ characters.

The ILA\_CNTRL register's SEL\_ILA[1:0] bits select which K28.3 /A/ symbol triggers the initial lane alignment: "00" = 1st /A/ symbol, "01" = 2nd /A/ symbol, "10" = 3rd /A/ symbol, "11" = 4th /A/ symbol; Table 86 on page 62. When all receivers have received their first selected /A/, they start propagating the received data to the frame assembly module at the same point in time.

This module can compensate for up to  $\pm 7$  frame clock period misalignments between the lanes.

When initial lane alignment is not supported, the manual alignment mode can be used.

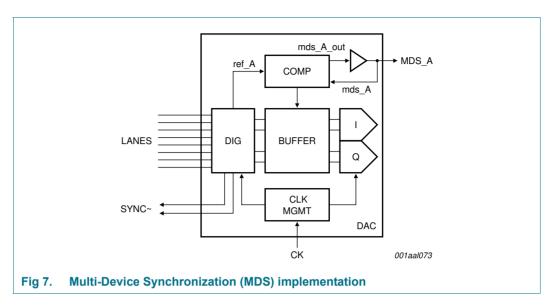
After the initial ILA sequence, the lane alignment monitoring starts. If the received user data contains K28.3 /A/ symbol:

- its position is compared to the value of the alignment monitor counter
- if two successive K28.3 /A/ symbols have been received at a wrong position, a realignment takes place
- if the buffers are empty or overflow, this is indicated by the registers ILA BUF ERR LN0 to ILA BUF ERR LN3

#### 10.2.5.2 Multi-device operation

DAC1008D750 implements a multi-device inter-lane alignment that guarantees a skew of less than one output period between them.

Two modes are available: master/slave and all slave. Both make use of the MDS\_P and MDS\_N pins.

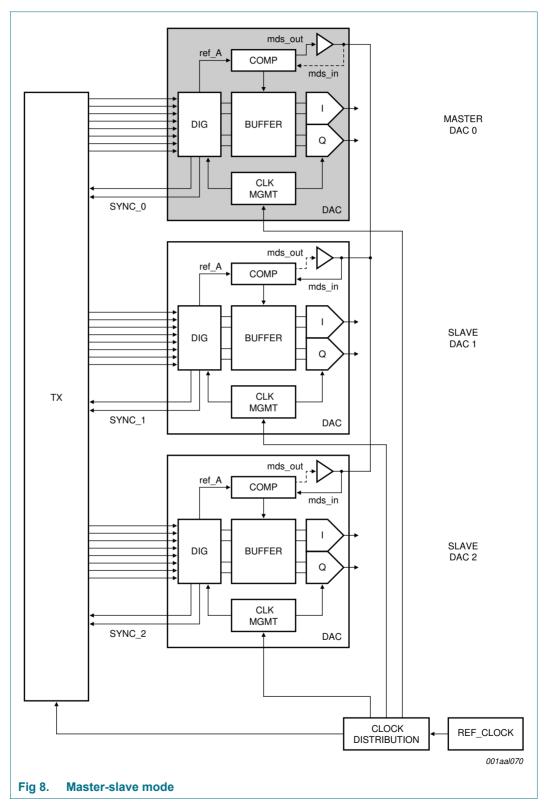


Each DAC device of the system generates its own reference (ref\_A in Figure 7).

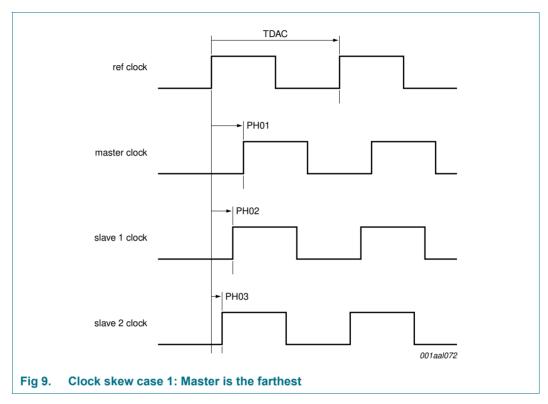
If configured as a slave, an early-late comparator compares the internal reference with the external reference provided by the MDS pins. The comparator controls an internal buffer that is used to delay the samples.

#### 10.2.5.3 Master/slave mode

The external reference is provided by one of the DACs (the master DAC), which has to be configured to do this. The others are set to slave mode.



The MDS signal generated by the master DAC must reach all slaves within one DAC output clock period. This induces PCB layout constraints for the MDS signal and also for the clock distribution. Because trace lengths differ, the clock edges will reach each of the DACs at different times.

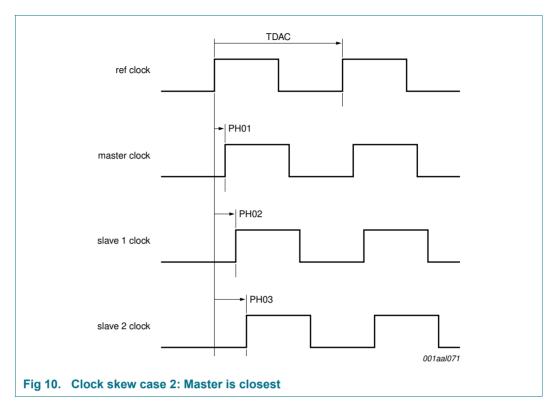


The worst case clock skew is given by  $\delta t_1$  = PH01 – PH03, where PH0x represents the sum of the trace delay and the clock skew at the output of the clock generator.

The maximum allowable trace delay for the MDS signal is given by  $\Delta t = TDAC - \delta t_1$ .

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2×, 4× or 8× interpolating DAC with JESD204A



The worst case clock skew is given by  $\delta t_2$  = PH03 – PH01.

The minimum allowable trace delay for the MDS signal is given by  $\Delta t = \delta t_2$ .

In real applications, the master DAC can be anywhere and both conditions must be satisfied:  $\delta t_2 < \Delta t_{mds} < TDAC - \delta t_1$ .

#### Example:

- clock generator skew = ± 80 ps
- FR4 substrate ⇒ 15 cm/ns delay
- clock trace length difference = 3 cm and 4 cm
- Output sampling rate = 750 Msps

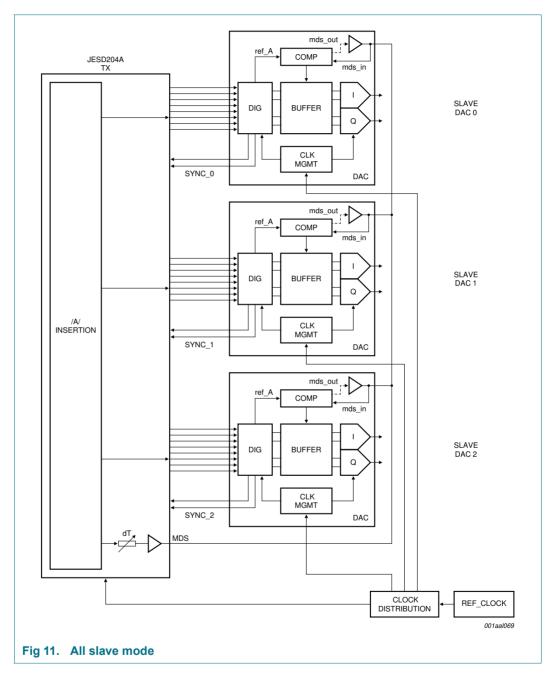
$$\Rightarrow$$
 200 ps + 80 ps <  $\Delta t_{mds}$  < 1333 ps - (266 ps + 80 ps)

$$\Rightarrow$$
 280 ps <  $\Delta t_{mds}$  < 987 ps

$$\Rightarrow$$
 4.2 cm < L<sub>mds</sub> < 14.8 cm

#### 10.2.5.4 All slave mode

The external reference is provided by the JESD204A transmitter. All DACs are configured in slave mode.



The MDS signal is now driven from the transmitter. It is generated at the end of the inter-lane alignment phase (see the JESD204A standard for details).

The transmitter must also compensate for the DAC latency. Although the DAC has an internal samples delay line, it cannot handle large delays.

In this mode, PCB layout is also important. The following delay equation applies:  $\delta t < \Delta t_{mds} < TDAC - \delta t$ , where  $\delta t$  is the clock skew considered close to DAC pins.

#### 10.2.6 Frame assembly

DAC1008D750 supports only /F/ = 1, which means that every frame clock period carries one byte per lane. Frame assembly combines the octet of lane\_0 with the two MSB bits of lane\_1 and reassembles the original 10-bit sample. The same is done for lane\_2 and lane\_3. Tail bits are dropped.

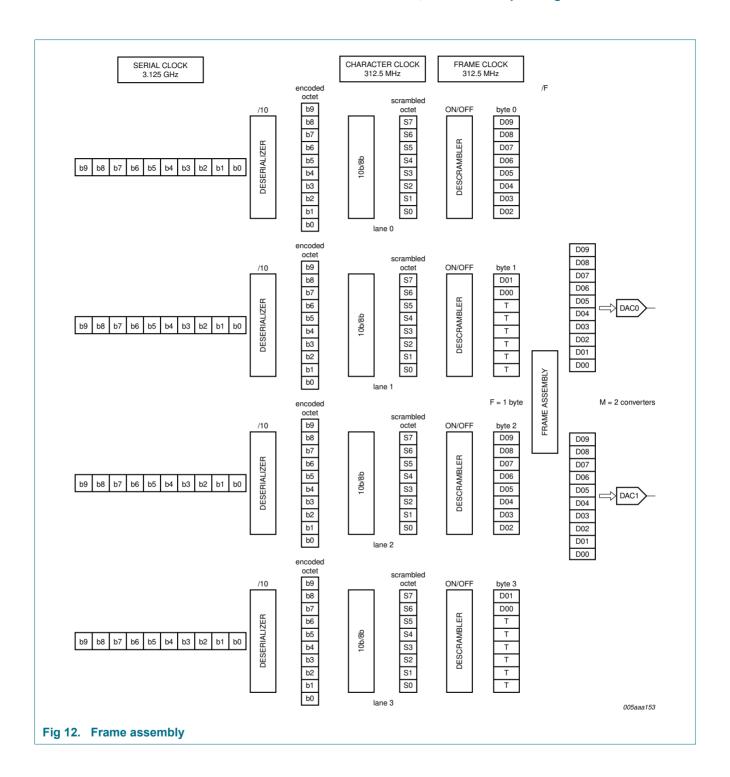
The frame assembler also handles previously triggered errors.

If scrambling is enabled:

If a nit\_err (not-in-table error) or kout\_unexp (unexpected control character) occurs in lane\_0 and/or lane\_1, the previous 10-bit sample is repeated twice for I (lane\_0, lane\_1). The same is done for Q (lane\_2, lane\_3).

If scrambling is disabled:

If a nit\_err (not-in-table error) or kout\_unexp (unexpected control character) occurs in lane\_0 and/or lane\_1, the previous 10-bit sample will be repeated once for I (lane\_0, lane\_1). The same is done for Q (lane\_2, lane\_3).



### 10.3 Serial Peripheral Interface (SPI)

#### 10.3.1 Protocol description

The DAC1008D750 serial interface is a synchronous serial communication port allowing easy interfacing with many industry microprocessors. It provides access to the registers that define the operating modes of the chip in both Write mode and Read mode.

This interface can be configured as a 3-wire type (SDIO as bidirectional pin) or a 4-wire type (SDIO and SDO as unidirectional pin, input and output port respectively). In both configurations, SCLK acts as the serial clock and SCS\_N acts as the serial chip select bar.

Each read/write operation is sequenced by the SCS\_N signal and enabled by a LOW assertion to drive the chip with two bytes to five bytes, depending on the content of the instruction byte (see Table 8).

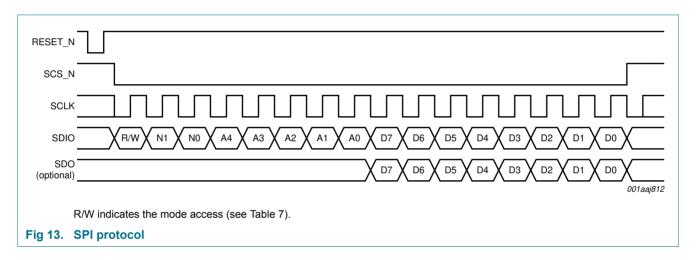


Table 7. Read or Write mode access description

R/W	Description
0	Write mode operation
1	Read mode operation

In Table 8 below, N1 and N0 indicate the number of bytes transferred after the instruction byte.

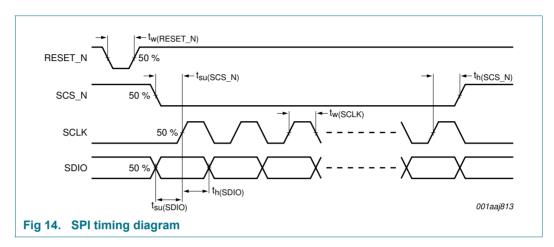
Table 8. Number of bytes to be transferred

N1	N0	Number of bytes transferred
0	0	1
0	1	2
1	0	3
1	1	4

A[4:0] indicates which register is being addressed. In the case of a multiple transfer, this address points to the first register to be accessed. The address is then internally decreased after each following data phase.

### 10.3.2 SPI timing description

The SPI interface can operate at a frequency of up to 15 MHz. The SPI timing is shown in Figure 14.



The SPI timing characteristics are given in Table 9.

Table 9. SPI timing characteristics

Symbol	Parameter	Min	Тур	Max	Unit
f <sub>SCLK</sub>	SCLK frequency	-	-	15	MHz
$t_{w(SCLK)}$	SCLK pulse width	30	-	-	ns
$t_{\text{su(SCS}_N)}$	SCS_N set-up time	20	-	-	ns
$t_{h(SCS\_N)}$	SCS_N hold time	20	-	-	ns
$t_{su(SDIO)}$	SDIO set-up time	10	-	-	ns
$t_{h(SDIO)}$	SDIO hold time	5	-	-	ns
$t_{w(\text{RESET\_N})}$	RESET_N pulse width	30	-	-	ns